## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | BARATIAN ET AL. | Examiner | Art Unit | Page 1 of 3

### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-1,829,231	10-1931	MERGENTIME CHARLES B	66/170
*	В	US-2,627,644	02-1953	FOSTER BOUTWELL H	428/175
*	С	US-2,902,038	09-1959	BLETZINGER JOHN C; et. al.	604/365
*	۵	US-3,150,693	09-1964	SELTZER NORMAN L	139/383R
*	Е	US-3,236,238	02-1966	MORSE EDWARD A	604/366
*	F	US-3,367,333	02-1968	SCHEIER STANLEY C	604/375
*	G	US-3,491,802	01-1970	OLDERMAN GERALD M; et. al.	139/420R
*	π	US-3,498,296	03-1970	GALLAGHER MARION C	604/372
*	-	US-4,037,601	07-1977	Denkinger, Marian C.	604/366
*	J	US-4,710,185	12-1987	Sneyd et al.	604/372
*	K	US-4,723,953	02-1988	Rosenbaum et al.	604/369
*	L	US-5,192,606	03-1993	Proxmire et al.	428/171
*	М	US-5,527,300	06-1996	Sauer, Barbara O.	604/378

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
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### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

## Notice of References Cited

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Examiner	Art Unit			
Paula L. Craig	3761	Page 2 of 3		

### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,536,555	07-1996	Zelazoski et al.	428/138
*	В	US-5,643,653	07-1997	Griesbach et al.	428/120
*	С	US-5,670,110	09-1997	Dirk et al.	264/504
*	D	US-5,824,352	10-1998	Yang et al.	425/290
*	E	US-5,896,680	04-1999	Kim et al.	36/28
*	F	US-5,925,026	07-1999	Arteman et al.	604/383
*	G	US-5,990,377	11-1999	Chen et al.	604/381
*	Н	US-6,015,936	01-2000	Takai et al.	604/383
*	ı	US-6,117,524	09-2000	Hisanaka et al.	428/137
*	J	US-6,803,334	10-2004	Mizutani et al.	442/394
*	κ	US-2003/0167044 A1	09-2003	Toyoshima et al.	604/367
*	L	US-2003/0203162 A1	10-2003	Fenwick et al.	428/156
*	М	US-2003/0203691 A1	10-2003	Fenwick et al.	442/327

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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### **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/749,627 Examiner Paula L. Craig Applicant(s)/Patent Under Reexamination BARATIAN ET AL. Page 3 of 3

### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0265533 A1	12-2004	Hoying et al.	428/092
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
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	М	US-			

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.